

MAR 21 2005

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 240004US0CONT	PATENT & TRADEMARK OFFICE		SERIAL NO. 10/614,811	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Masahiko OGAWA, et al.				
				FILING DATE July 9, 2003		GROUP 1751		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
EE	AA	5,817,155	10/06/98	YASUDA et al. (corr. to JP 10-67624)	86	406		
EE	AB	6,071,504	06/06/00	KAWAI et al. (corr. to JP 11-180837)	924	70,12		
EE	AC	5,368,610	11/29/94	CHAN et al. (corr. to JP 7-2637)	8	406		
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
	AL							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION			
YES	NO							
EE	AM	11-343219	12/14/99	JAPAN w/English abstract			XX	
EE	AN	10-67624	03/10/98	JAPAN w/English abstract (corr. to US 5,817,155)			XX	
EE	AO	8-40853	02/13/96	JAPAN w/English abstract			XX	
EE	AP	10-279591	10/20/98	JAPAN w/English abstract			XX	
EE	AQ	7-228514	08/29/95	JAPAN w/English abstract			XX	
EE	AR	11-180837	07/06/99	JAPAN w/English abstract (corr. to US 6,071,504)			XX	
EE	AS	7-2637	01/06/95	JAPAN w/English abstract (corr. to US 5,368,610)			XX	
EE	AT	7-233035	09/05/95	JAPAN w/English abstract			XX	
EE	AU	5-97637	04/20/93	JAPAN w/English abstract			XX	
EE	AV	6-62396	08/17/94	JAPAN w/English abstract			XX	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ	<input type="checkbox"/> Additional References sheet(s) attached						
Examiner	Sieg Caullo		Date Considered 5/12/05					
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								